

Search Notes				Application/Control No.	Applicant(s)/Patent under Reexamination
				09/855,828	CREECH ET AL.
Examiner				Art Unit	
Jon M. Lockard				1647	

SEARCHED			
Class	Subclass	Date	Examiner
435	252.3	10/26/2004	JML
435	254.11	10/26/2004	JML
435	320.1	10/26/2004	JML
435	325	10/26/2004	JML
530	350	10/26/2004	JML
536	23.1	10/26/2004	JML
536	23.5	10/26/2004	JML
536	24.3	10/26/2004	JML
NONE		1/31/2006	JML

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
East Search (US PAT, US P6-PUB, See Attached Search History)		7/19/2006	JML
PALM: Inventor Search		7/19/2006	JML
STIC Search of SEQ IDNOS: 1, 2, + 3		7/19/2006	JML

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
STIC Search of Commercial and Patent Databases: See Attached Search Report.	6/24/2004	JML
STN Text Search: See Attached Search Results.	10/8/2004	JML
East Search: Inventor's Name Search: See Attached Search Report.	10/26/2004	JML
PALM: Inventor's Name Search: See Attached Search Report.	10/26/2004	JML
STIC Search of Commercial and Patent Databases: See Attached Search Report.	1/31/2006	JML
East Search Updated (USPAT, US-PGPUB, EPO, DERWENT: Inventor Name and Text Search. See Attached Search History.	1/31/2006	JML
STN (MEDLINE, SCISEARCH, EMBASE, BIOSIS): See Attached Search History.	1/31/2006	JML
PALM: Inventor Search.	1/31/2006	JML